

Search Notes

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10/725,495

Examiner

Tai T. Nguyen

Applicant(s)/Patent under
Reexamination

FRANK, RUTH

Art Unit

2612

SEARCHED

Class	Subclass	Date	Examiner
340	568.1 566 571 691	1/18/2007	TN
705	2 3	1/18/2007	TN
206	557 561 581	1/18/2007	TN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR